


<b>Search Notes</b> 	<b>Application/Control No.</b> 10510328	<b>Applicant(s)/Patent Under Reexamination</b> CICHUTEK ET AL.
	<b>Examiner</b> MARIA B MARVICH	<b>Art Unit</b> 1633

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN, East search updated, search notes attached	7/28/08	MM
Search updated, search notes attached	4/25/09	MM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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